

IAP20 REGISTRATION NO. 16 DEC 2005

USPTO form PTO/SB/08A

Page 1 of 1

Subst. Form PTO-1449		Atty. Dkt No.: PHUS030183US	Serial No.: 10/560872 10/560,872
APPLICANT(S)'S INFORMATION		Applicant(s): Ulrich KATSCHER, et al.	
DISCLOSURE STATEMENT		Filing Date: <i>herewith</i> <i>14 December 2005</i>	Group: unknown <i>2859</i>

U.S. PATENT DOCUMENTS

Initial		Document No.	Date	Name	Class	Subcl	Filing Date
TAF	AA	6,166,545	12-26-2000	Polzin, et al.	324	309	12-22-1998
TAF	AB	6,242,916	06-05-2001	King	324	309	11-17-1999
TAF	AC	2002/0042568 A1	04-11-2002	Fuderer, et al.	600	410	08-27-2001
TAF	AD	6,380,741 B1	04-30-2002	Hajnal, et al.	324	318	11-15-2000
TAF	AE	6,396,269 B1	05-28-2002	Hajnal, et al.	324	307	11-15-2000
TAF	AF	2003/0030437 A1	02-13-2003	Bydder, et al.	324	309	04-19-2002
TAF	AG	2003/0052676 A1	03-20-2003	Takahashi, et al.	324	307	12-08-2000

FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country			Translation ?
TAF	AH	EP 1 102 076 A2	05-23-2001	Europe-Marconi			

OTHER ART

TAF	AI	RD 445087 Multidimensional SENSE with Non-Factorized Reduction Factor, May, 2001; p. 796.
TAF	AJ	KATCHER, U., et al.; Theory and experimental verification of transmit SENSE; 2002; Proc. Int'l. Soc. Mag. Reson. Med.; 10; p. 189
TAF	AK	PRUESSMANN, K.P., et al.; SENSE: Sensitivity Encoding for Fast MRI; 1999; MRM; 42:952-962.

Examiner: <i>Jiffany A. Tegner</i>	Date Considered: <i>May 8th 2007</i>
* EXAMINED: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if in conformance and not considered. Include copy of this form with next communication to applicant.	